

# **De-Integrating Integrated Circuit Preamps**

**Less Delivers More?**

**Les Tyler, President, THAT Corporation**

# Today's Topics

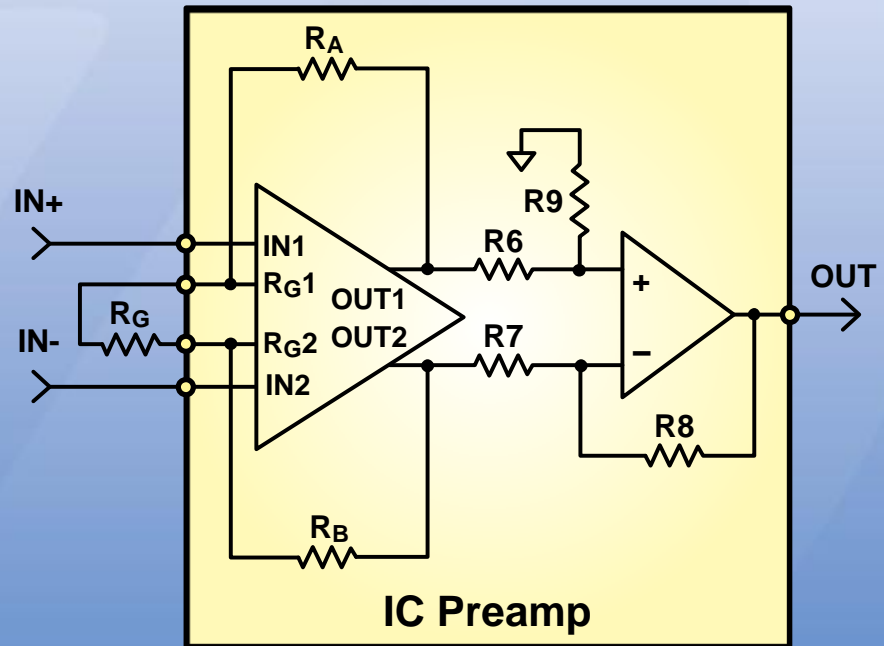
- **Where we've been, and where we're going**
  - The old to the “new” topology
- **Optimizing this new topology**
  - Noise
  - Bandwidth
  - Gain control, taper, & dc offset
  - Output configuration
- **Wrap-up**

# **Out with the Old ... In with the New**

Some historical perspective...

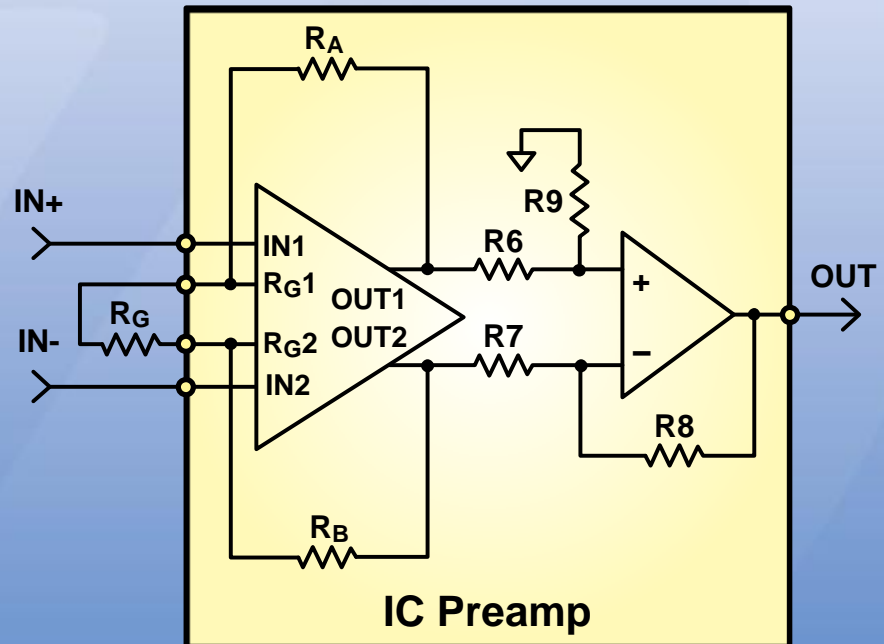
# In the Beginning (for IC Preamps)

- Solid State Music
  - Ron Dow
  - Dan Parks
- SSM 2011 (~1982)
  - Integrated preamp
  - External feedback
- SSM2015 (~1983)
  - Integrated preamp
  - One external resistor controls gain:  $R_G$



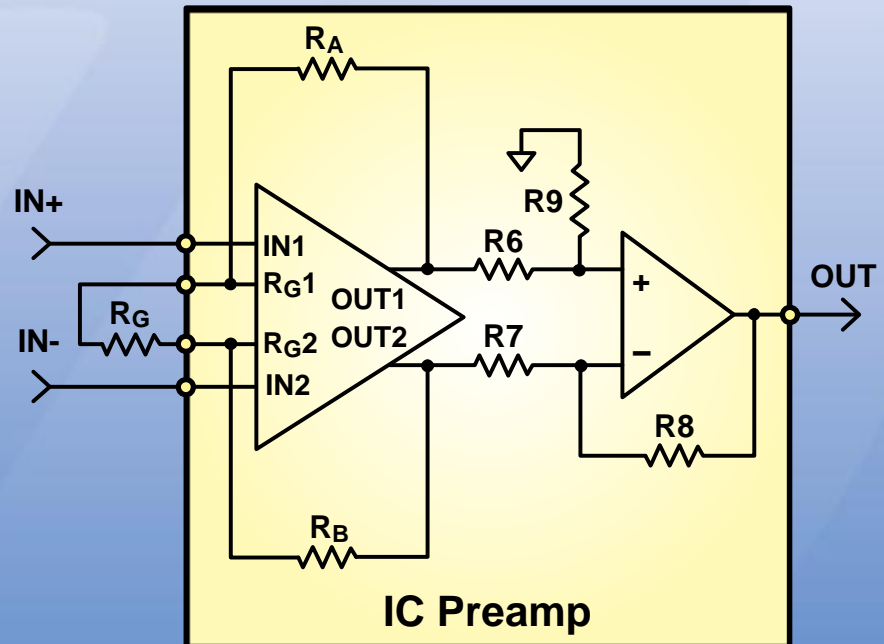
# “Standard” IC Preamp Configuration

- Differential input
- Single-ended output
- Current feedback
- Single resistor controls gain
  - $R_G$
- Minimum gain: 0dB
  - Requires infinite  $R_G$



# Many Followed In SSM's Footsteps

- SSM2016 (1986)
  - Derek Bowers' design
- SSM2017 (1989)
  - By this time, SSM was part of Analog Devices
- SSM2019 (2003)
  - Derek Bowers (at ADI)
- TI INA163 (~2000)
  - INA217 (2002)
- THAT 1510 (2004)
- THAT1512 (2004)
  - External  $R_G$
  - Diff-amp gain: -6dB
  - Credit: Cal Perkins (at Mackie)
- Not considered: AD524 (1982)
  - Also included internal  $R_A$  &  $R_B$ , as well as choice of (internal)  $R_G$
  - Scott Wurcer's design
  - Noise too high for a mic preamp ( $\sim 5\text{nV}/\sqrt{\text{Hz}}$ )



# Benefits of “Standard” Topology

- Wide bandwidth at high gain due to current, not voltage feedback
- Can be very quiet at high gains
  - Many reach  $1\text{ nV}/\sqrt{\text{Hz}}$  voltage noise
- Easy to control gain with single  $R_G$
- Integrated approach allows wide input dynamic range
  - See G. Hebert’s presentation at the 2010 US AES convention

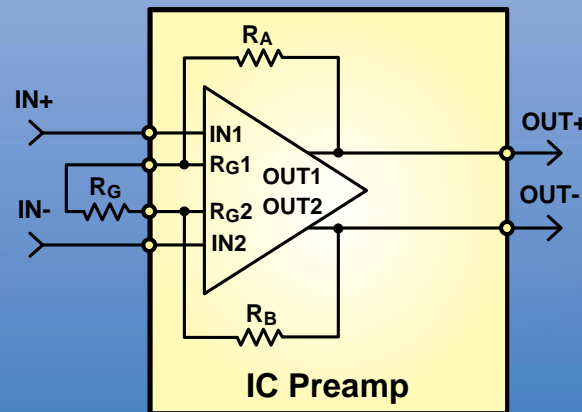
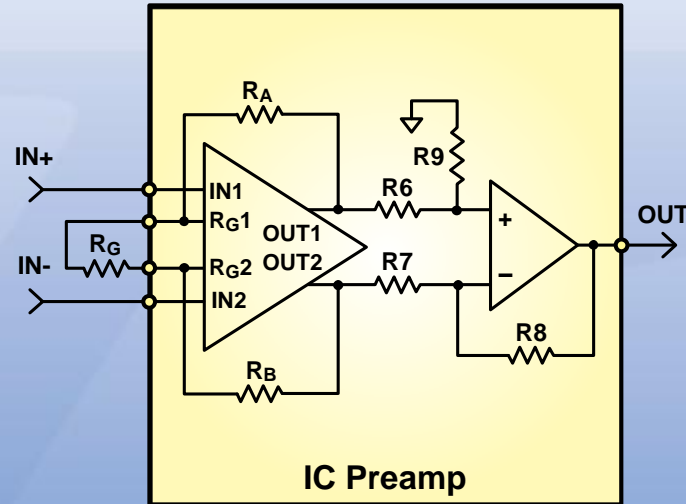
# Detriments of “Standard” Topology

- Feedback network adds noise at low gains
  - Resistor self-noise
  - Current noise in  $R_G$  pins drawn across the feedback network's impedance
- Maximum gain is affected by pot's effective end-resistance
- Smooth taper is hard to achieve
  - Depends on  $R_G$  vs.  $R_A$  &  $R_B$
- Must convert output from single-ended to differential to drive A/D converters



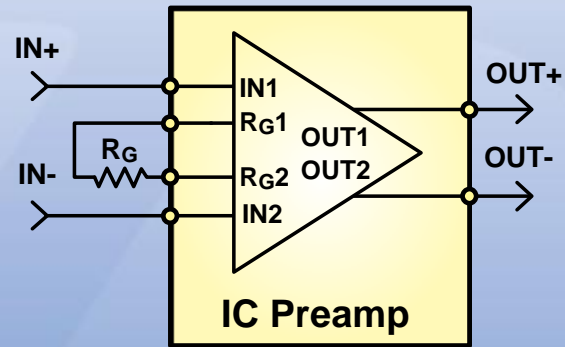
# Let's De-Integrate the Topology

- Start with the "standard" IC
- Remove the output diff amp

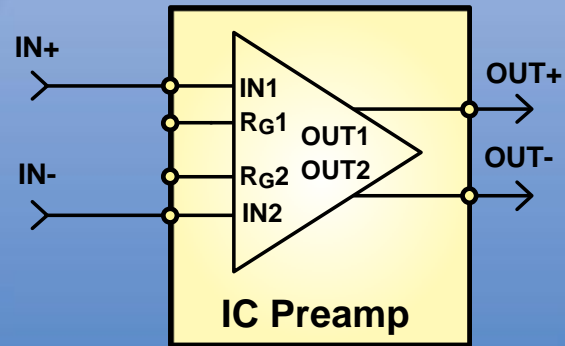


# Let's De-Integrate the Topology

- Remove internal  $R_A$  &  $R_B$

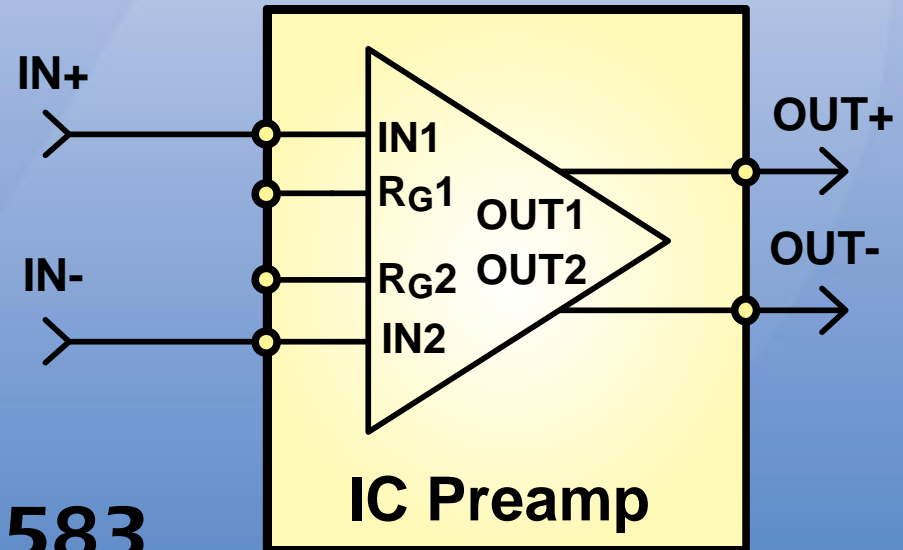


- Take away the external  $R_G$



# What Does That Leave?

- **Uncommitted**
  - Completely configurable
- **Differential In**
- **Differential Out**
  - 0dB common-mode gain
- **Current Feedback**
- **Low Voltage Noise**
- **THAT's the 1570 & 1583**



# **The 1570/1583 “Uncommitted” Topology Makes Optimization Easy**

- **Noise vs. gain**
- **Bandwidth vs. gain**
- **Pot end resistance**
- **Gain vs. pot rotation**
- **Output amp performance**
  - **Noise**
  - **CMRR**

# Optimization Details

Noise

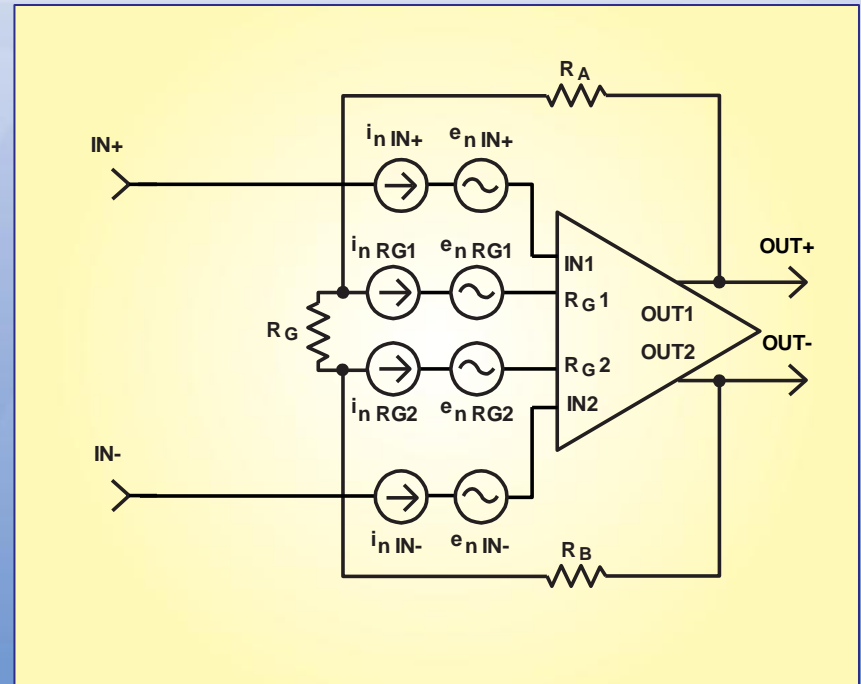
Bandwidth

Gain control, taper & DC offset

Output & Common-Mode Rejection

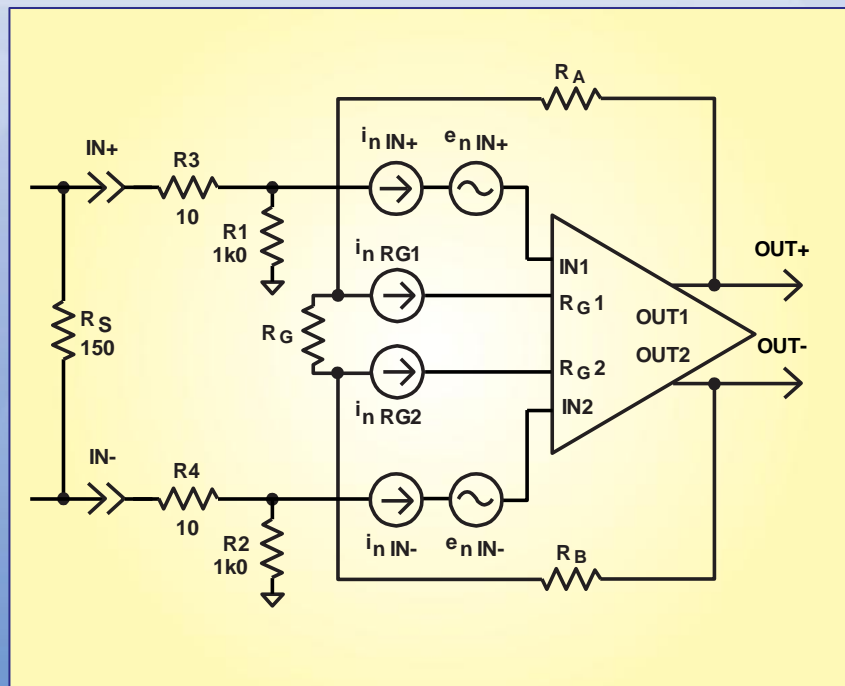
# Noise Model for 1570/1583-Type Preamp

- Voltage ( $e_n$ ) & Current ( $i_n$ ) noise flows in each input pin
- $e_n$  is amplified by gain
  - 0dB at minimum gain
  - +60dB at 60dB gain
- $i_n$  creates a noise voltage based on the impedance it flows through
  - Then amplified by gain
- Sources are uncorrelated
  - Add in RMS fashion (root of the sum of the squares)



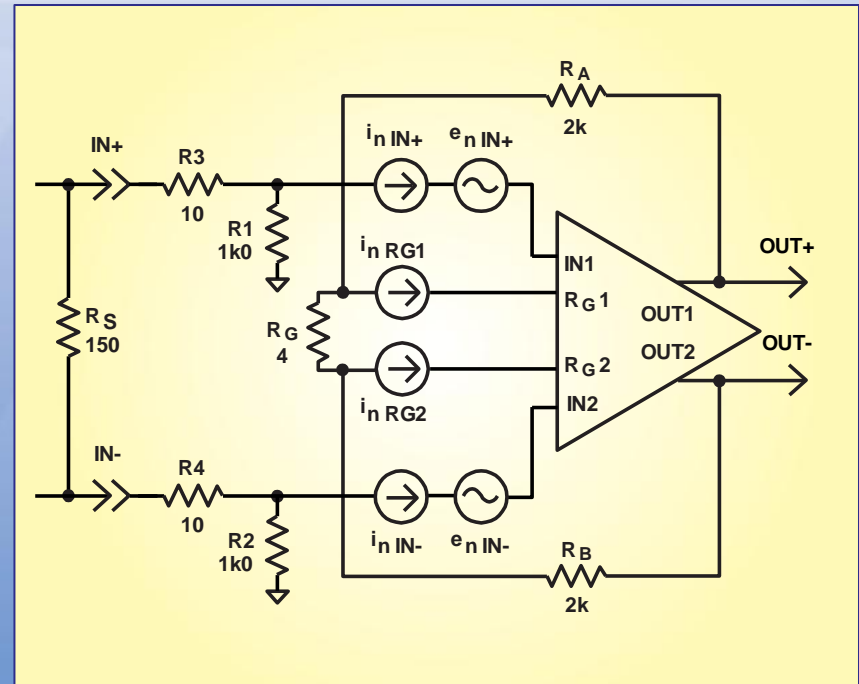
# Noise Model for 1570/1583-Type Preamp

- $e_{nRG}$  can be lumped into the  $e_{nIN+}$  and  $e_{nIN-}$  sources
- Contributions of  $i_{nIN+}$  &  $i_{nIN-}$  depend on source impedance at  $IN+$  &  $IN-$   
 $= (R_3 + R_4 + R_S) \parallel (R_1 + R_2)$
- Contribution of  $i_{nRG}$  depends on feedback network impedance  
 $= (R_A + R_B) \parallel R_G$   
 – Current times impedance generates the voltage
- Because gain varies with  $R_A$ ,  $R_B$  &  $R_G$ , relative contribution of each source depends on gain



# 1570/1583 Noise At High Gains (60dB shown)

- $R_G$  is small, so  $i_{nR_G}$  contribution is small
- $R_S$  is small, so the  $i_{nIN+}$  &  $i_{nIN-}$  contributions are small
  - But, if  $R_S$  is large (e.g., open inputs),  $i_{nIN}$  contributions can be significant
- $e_{nIN+}$  &  $e_{nIN-}$  dominate, along with the self-noise of  $R_S$

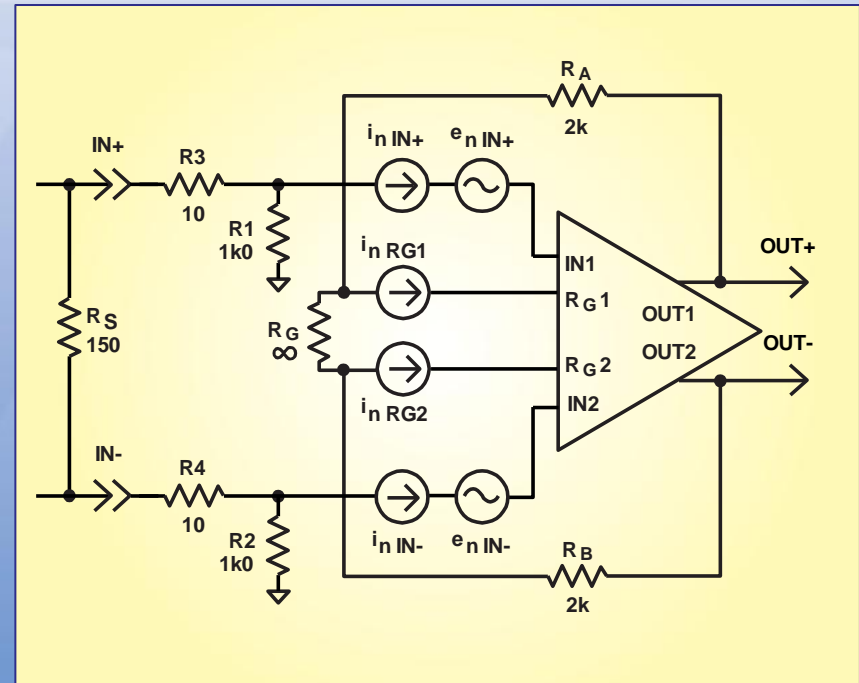


High-gain noise depends more on IC characteristics and source impedance than anything else



# 1570/1583 Noise At Low Gains (0dB shown)

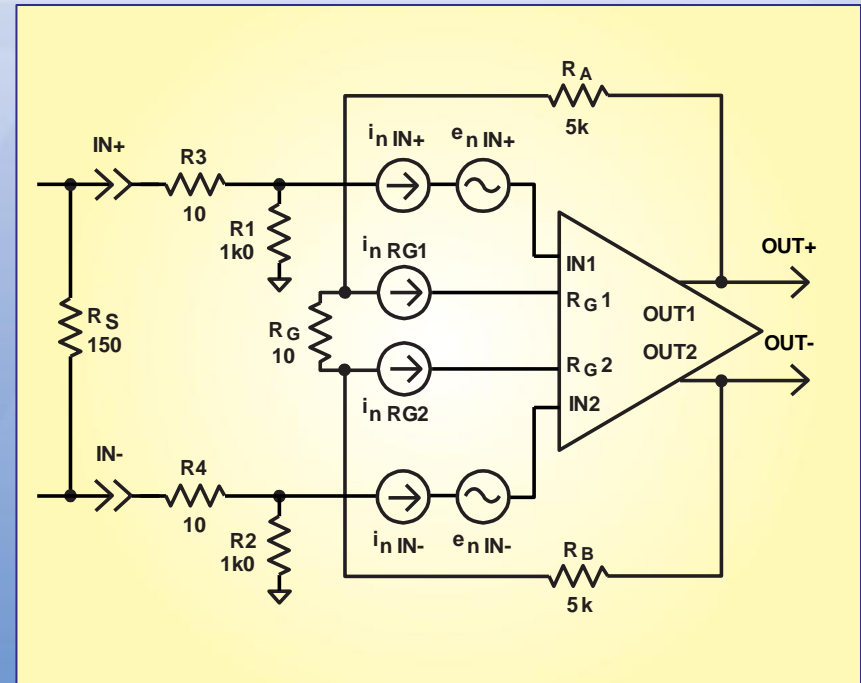
- $e_{nIN+}$  &  $e_{nIN-}$  are small, along with the self-noise of  $R_S$
- $R_S$  is small, so the  $i_{IN+}$  &  $i_{IN-}$  contributions are small
- $R_G$  is open, so the two  $i_{nRG}$  currents flow through  $R_A$  &  $R_B$ 
  - $i_{nRG}$  currents dominate the noise floor
- To reduce noise at low gains, reduce  $R_A$  &  $R_B$



Low-gain noise depends more on IC characteristics and feedback ( $R_A$  &  $R_B$ ) impedance than anything else

# 1510 (Front End) Noise At High Gains (60dB Shown)

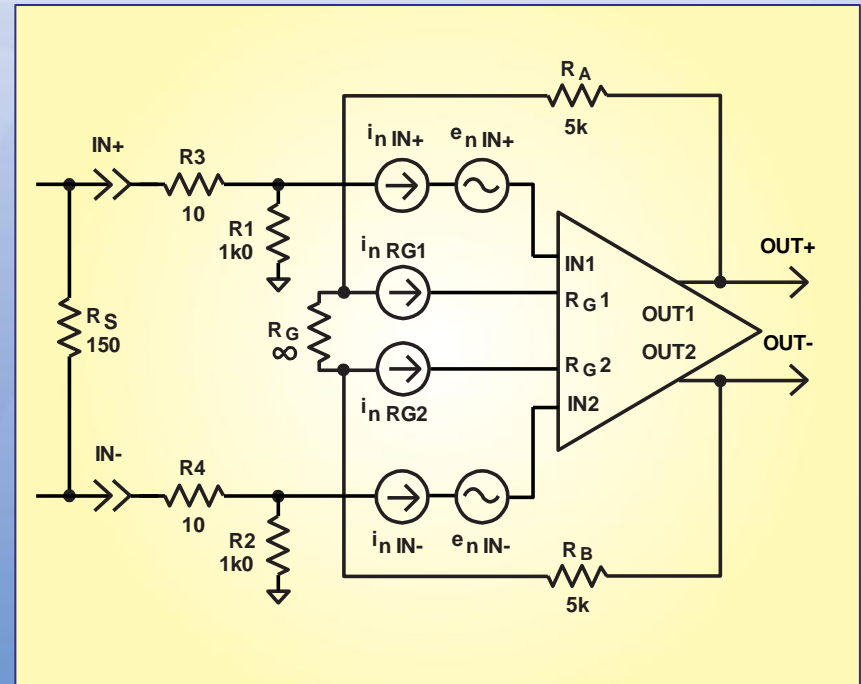
- $R_G$  is small, so  $i_{nR_G}$  contribution is small
- $R_S$  is small, so the  $i_{nIN+}$  &  $i_{nIN-}$  contributions are small
  - As with 1570, if  $R_S$  is large (e.g., open inputs),  $i_{nIN}$  contributions can be significant
- $e_{nIN+}$  &  $e_{nIN-}$  dominate, along with the self-noise of  $R_S$



High-gain noise depends more on IC characteristics and source impedance than anything else

# 1510 (Front End) Noise At Low Gains (0dB Shown)

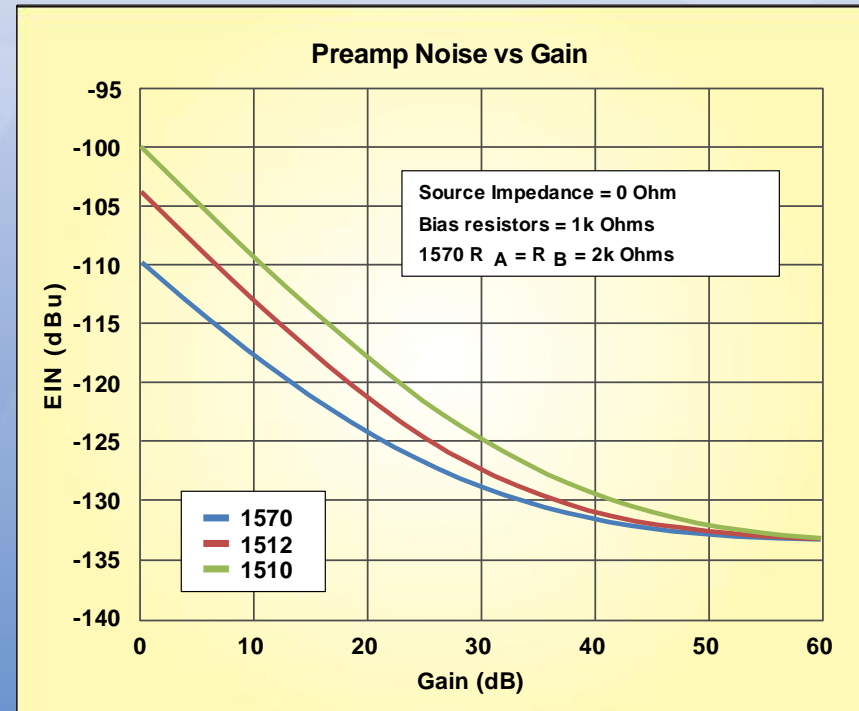
- $e_{nIN+}$  &  $e_{nIN-}$  are small, along with the self-noise of  $R_S$
- $R_S$  is small, so the  $i_{nIN+}$  &  $i_{nIN-}$  contributions are small
- $R_G$  is open, so  $i_{nRG1}$  flows through  $R_A$ , &  $i_{nRG2}$  flows through  $R_B$ 
  - $i_{nRG}$  currents dominate the noise floor
- Since  $R_A$  &  $R_B$  are fixed (internal), designers don't have freedom to affect this noise source



Noise at low gains depends only on IC characteristics: no flexibility with the “standard” topology

# Controlling Noise: “Standard” vs. “New” Topology

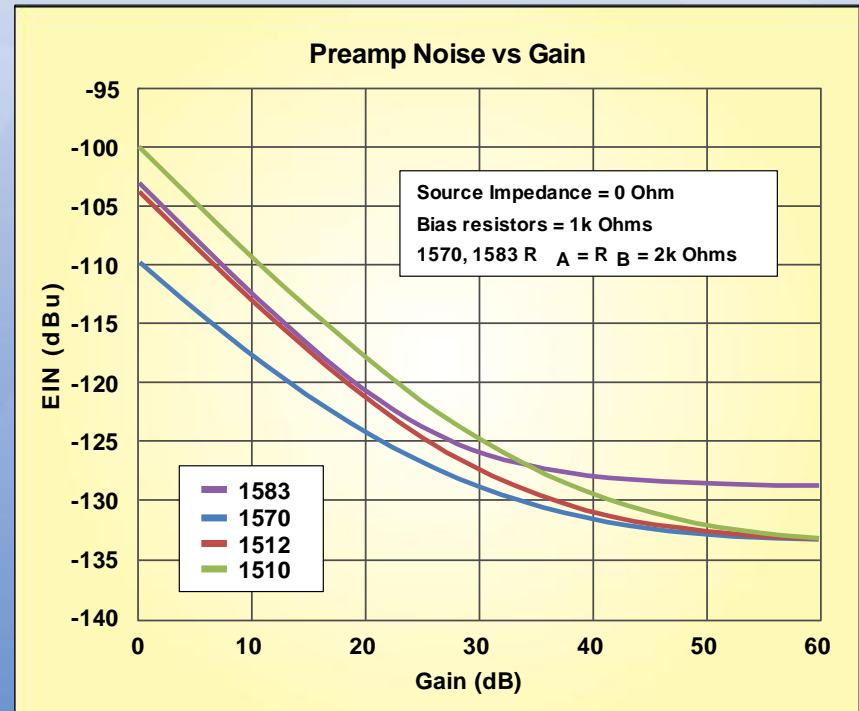
- High-gain noise is same ( $1\text{nV}/\sqrt{\text{Hz}}$ ) across 1510, 1512, & 1570
- Low-gain noise can be controlled in new topology, but not in standard topology
  - Requires the designer to supply  $R_A$  &  $R_B$



1570's 0dB gain noise is  
~9dB lower compared to 1510,  
~5dB lower compared to 1512

# Controlling Noise: “Standard” vs. “New” Topology

- 1583 high-gain noise (1.9 nV/ $\sqrt{\text{Hz}}$ , or 5.6dB) is higher than 1510, 1512, & 1570
- But, low-gain noise for the 1583 is almost as low as the 1512
- New topology preserves better low-gain noise, even with a higher-noise part



1583's 0dB gain noise is  
~3dB lower than 1510  
~1.4dB higher than 1512

# Optimization Details

Noise

**Bandwidth**

Gain control, taper & DC offset

Output & Common-Mode Rejection

# Optimizing Bandwidth Vs. Gain

- Bandwidth is determined by amplifier design and feedback resistor ( $R_A$  &  $R_B$ )
- In 1510/12, you're limited to  $R_A = R_B = 5k\Omega$
- In 1570 & 1583, you can vary  $R_A$  &  $R_B$ 
  - Lower values => higher bandwidth
  - Minimum value is  $2k\Omega$

Part	Gain (dB)	0	6	10	20	30	40	50	60	
1510		10.39	10.22	10.14	9.95	9.48	8.11	5.25	2.28	MHz
1512		11.95	11.84	11.65	11.15	9.76	6.66	3.04	1.07	MHz
1570 (2k $\Omega$ )		16.78	16.78	15.65	12.71	7.83	3.65	1.38	0.46	MHz
1570 (5k $\Omega$ )		4.19	4.19	4.19	3.91	3.41	2.41	1.12	0.43	MHz
1570 (10k $\Omega$ )		1.93	1.91	1.91	1.86	1.72	1.39	0.87	0.40	MHz
1583 (2k $\Omega$ )		13.97	13.00	12.01	8.73	4.33	1.69	0.59	0.19	MHz
1583 (5k $\Omega$ )		3.92	3.60	3.40	2.95	2.20	1.24	0.52	0.19	MHz
1583 (10k $\Omega$ )		1.56	1.50	1.47	1.38	1.19	0.84	0.44	0.17	MHz

# Optimization Details

Noise

Bandwidth

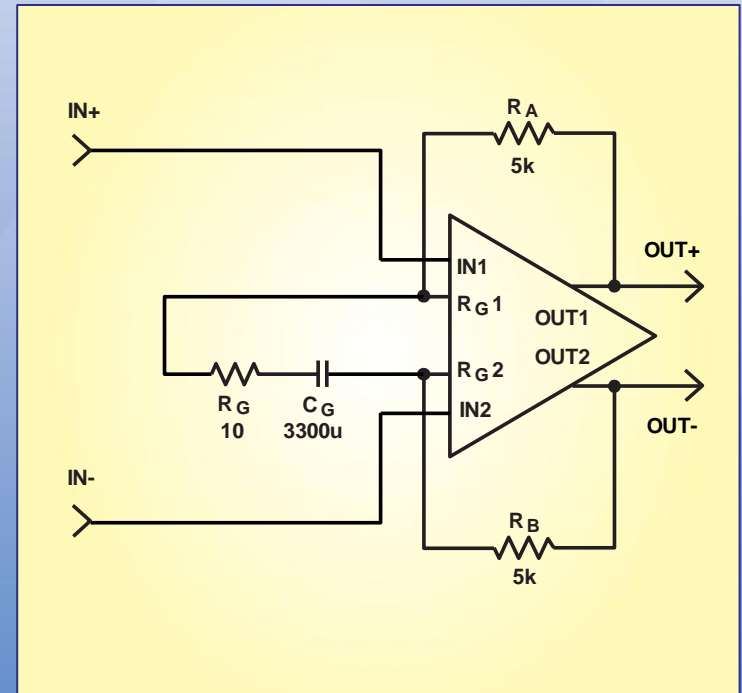
Gain control, taper & DC offset

Output & Common-Mode Rejection



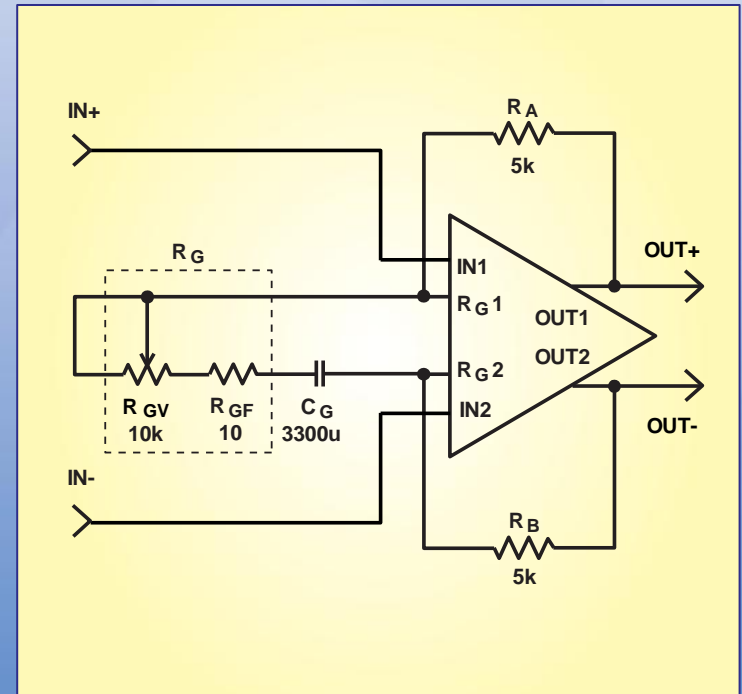
# Practical Considerations for $R_A$ & $R_B$

- $R_G$  is determined by maximum gain and  $R_A$ ,  $R_B$  values
- To minimize output (differential) offset with gain, use  $C_G$
- $C_G$  works against  $R_G$  to determine LF cutoff ( $f_0$ )
  - Small  $R_G$  and low  $f_0$  means big  $C_G$



# Varying Gain in the “Standard” Circuit

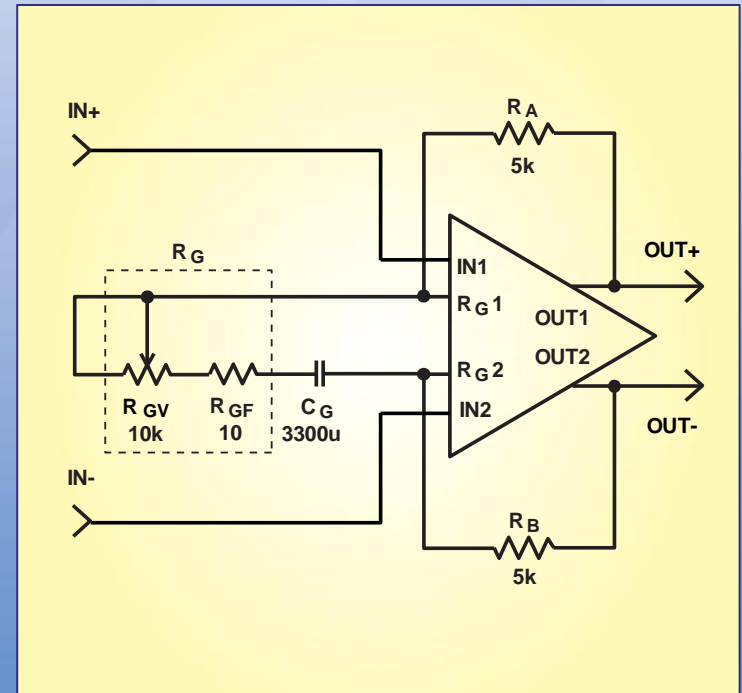
- $R_G$  varies to set gain
- Max gain when  $R_{GV}$  is maximum
- Min gain when  $R_{GV}$  is minimum
- Highest low-frequency cutoff occurs at max gain
- $C_G$  depends on desired LF cutoff and  $R_{GF}$  value



$$C_G = 3300\mu\text{f}, R_G = 10\Omega, f_o = 4.43\text{Hz}$$

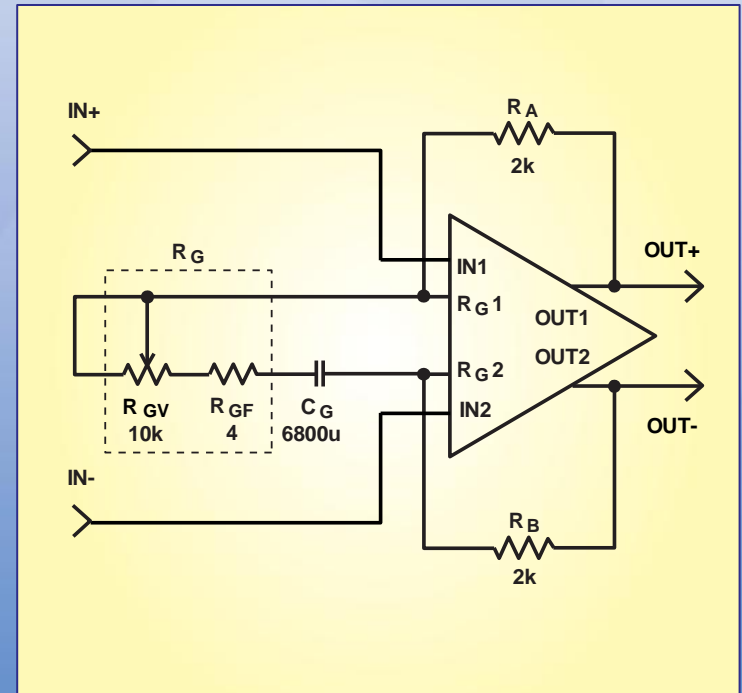
# Practical Considerations for Varying Gain in the “Standard Circuit”

- Effective end resistance in  $R_{GV}$  limits max gain
  - Reduce  $R_{GF}$  to offset
  - Variation in effective end resistance will alter max gain
- Pots used by APB Dynasonics have  $2 \sim 3\Omega$  (measured) end resistance
- Thanks to John Petrucelli for samples!
  - Check *your* spec sheet for your tolerances ...



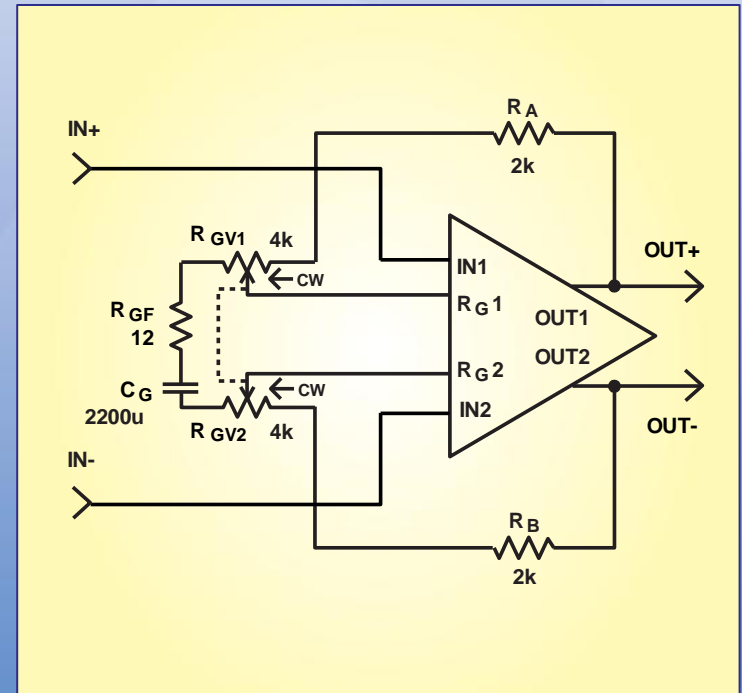
# Practical Considerations for Varying Gain in the “New” Circuit

- The conventional circuit is shown at right
- To minimize low-gain noise, select  $R_A$  &  $R_B$  as low as possible
  - For 1570, that’s  $2k\Omega$
  - For 1583, that’s  $??\Omega$
- For 60dB gain,  $R_{GF} = 4\Omega$
- End resistance may be a significant fraction of  $R_{GF}$
- To maintain  $< 5\text{Hz}$  cutoff,  $C_G > 7300\mu\text{f}$ 
  - That’s a big, expensive cap
  - Is  $< 5\text{Hz}$  cutoff a good idea at 60dB gain?



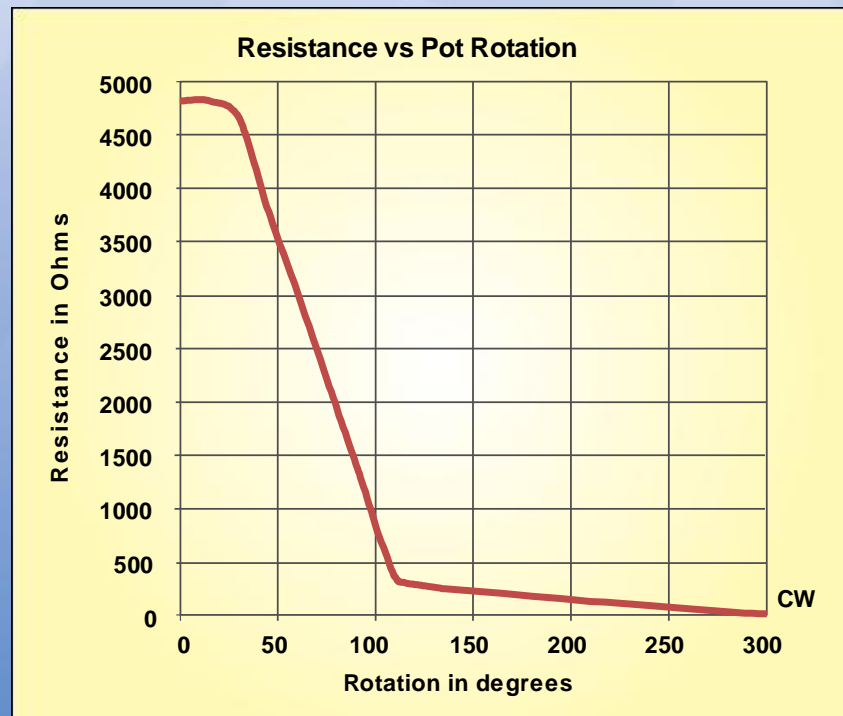
# Consider a Dual-Element Pot to vary $R_G$ , $R_A$ & $R_B$ Simultaneously

- Using a dual-element pot allows  $R_A$  &  $R_B$  to vary in addition to  $R_G$ 
  - Lowers  $R_A$  &  $R_B$  at min gain, but raises them at max gain
- This allows smaller  $C_G$  for the same cutoff
  - In circuit shown  $f_o \approx 5.5\text{Hz}$
  - 60dB gain noise is still very low:  $1.18\text{nV}/\sqrt{\text{Hz}}$  (-129.1dBu with  $150\Omega$  source)



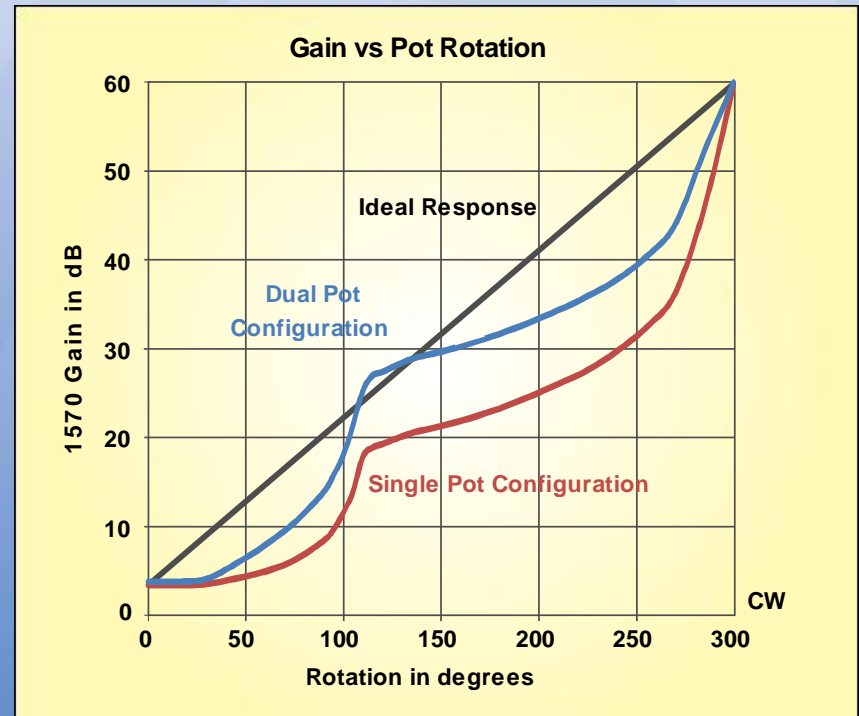
# Pot Taper

- Measured taper of “5% reverse log” taper pots (thanks to APB)
- Actually two linear sections with different resistances in each section
- What curve of gain vs. rotation will this produce?



# Gain vs. Rotation Compared: Single and Dual-Element Circuits

- Theoretical “ideal” curve shown in black
- Single-element pot (circuit of slide 26) results in red curve
- Dual-element pot (circuit of slide 29) results in blue curve
- Dual-element pot trajectory is much closer to “ideal”



# Optimization Details

Noise

Bandwidth

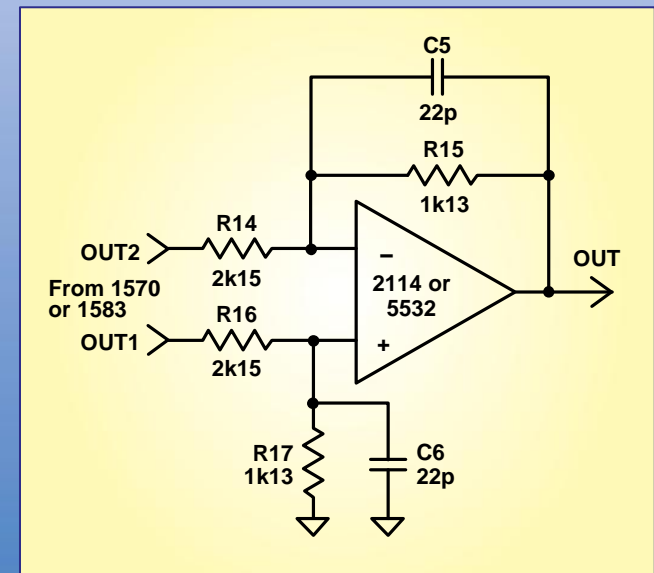
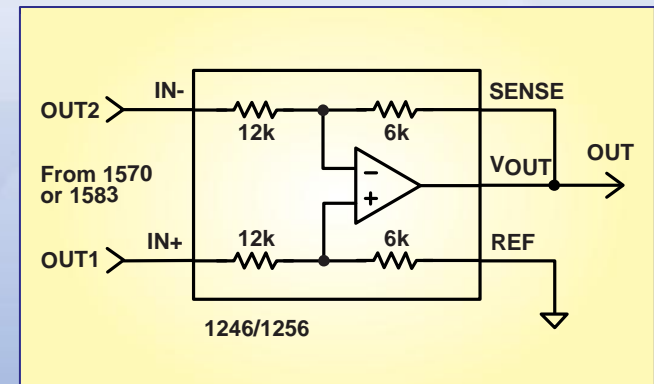
Gain control, taper & DC offset

Output & Common-Mode Rejection



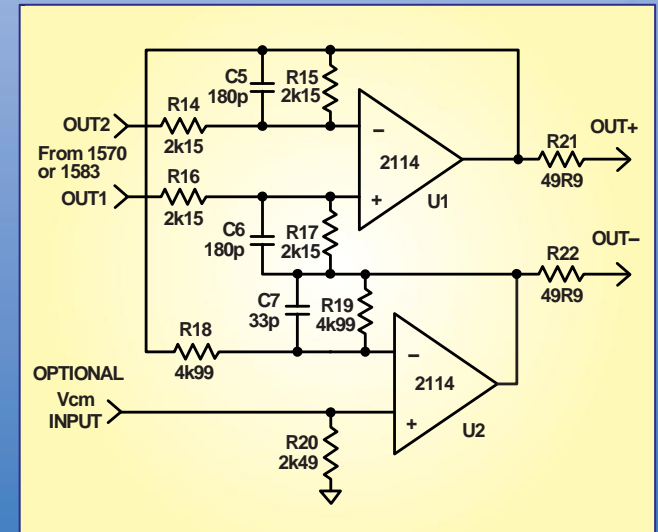
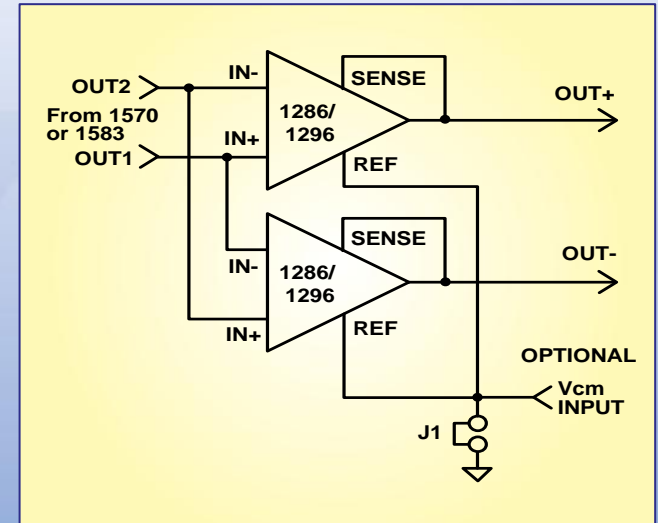
# Single-Ended Output Stages

- The 1570/1583 topology is differential in, differential out
  - Common-mode gain is always unity (0dB)
  - Differential gain varies with  $R_G$ ,  $R_A$ , &  $R_B$  (0~>60dB)
  - CMRR is equal to differential gain
  - Output has a (negative) common-mode DC offset of 1 diode drop (~-0.6V)
- To provide CMR at low gains, add a differential amplifier after the 1570/1583
- Choose carefully to avoid adding noise and limiting bandwidth
  - 1510/1512 includes a pretty quiet, wide-band amp
  - 1570/1583 allows designers flexibility in choosing this amplifier for even greater performance
  - Circuit at right (w/ 2114) compromises low-gain noise floor by only ~2.6 dB (for the 1570) and ~0.14 dB (for the 1583)



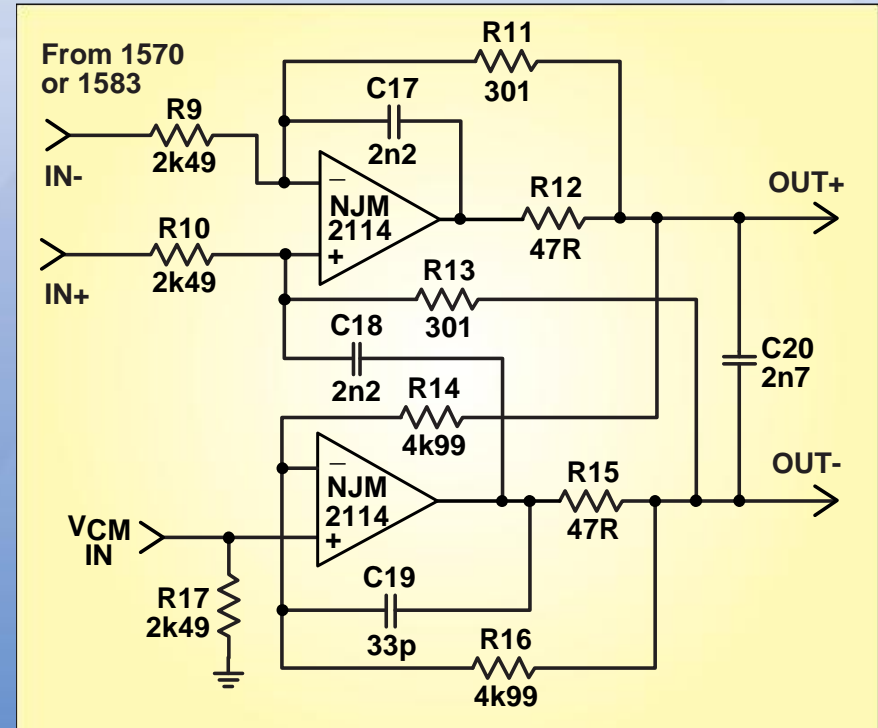
# Differential Output Stages

- In many cases (e.g., driving ADC), differential outputs are needed
- But, many designers want to remove common-mode signals
- Simple circuit (top, using 1286) has great common-mode rejection, fair noise performance
- More complex circuit (bottom, after Birt) maintains very low differential noise, but common-mode rejection depends on resistor matching



# Differential Output Stages

- Variation of Birt circuit suggested for driving A/D converters
  - Includes attenuation suitable for  $\sim 2V_{RMS}$  differential drive
- 1570/1583 differential output allows designers to spend on high-performance circuits & opamps when necessary, or save money when cost is more important than performance



# Summing Up

Why choose the “new” topology?

# Summary

- “New” 1570 & 1583 topology is a subset of the “standard” one
- Removing feedback resistors gives designers freedom to change their values
  - Optimize noise
  - Optimize bandwidth
  - Minimize blocking capacitor value while maintaining optimum noise performance
  - Optimize gain vs. rotation for analog control
- Removing output amp offers more flexibility
  - Naturally provides a differential output
  - Allows designer to set common-mode rejection
  - Optimize noise performance
- Less really is more!

# Thank You to ...

- Joe Lemanski (THAT's Applications Engineering Manager), for many of the facts & figures contained herein
- Gary Hebert (THAT's Chief Technical Officer) & Fred Floru (THAT's Principal IC Design Engineer) for general review and much tutoring in  $R_A/R_B$ 's influence on noise
- Dave Lail (THAT's Art Director) for providing the drawings, and putting up with endless revisions
- Steve Green (THAT's Technical Marketing Manager) for many suggestions
- Dan Parks (now President of Cruz Tools, was the marketing guy at SSM), for help with early preamp chronology and credits.
- All of you in the audience for attending and supporting us!